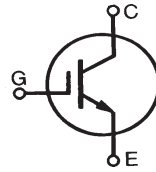
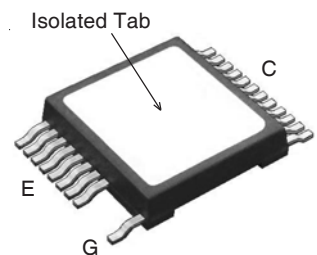
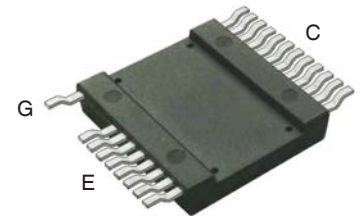


**XPT™ 600V IGBT
GenX3™**
MMIX1X200N60B3
(Electrically Isolated Tab)

 Extreme Light Punch Through
IGBT for 10-30kHz Switching

$$\begin{aligned}
 V_{CES} &= 600\text{V} \\
 I_{C110} &= 120\text{A} \\
 V_{CE(sat)} &\leq 1.7\text{V} \\
 t_{fi(typ)} &= 110\text{ns}
 \end{aligned}$$

| Symbol | Test Conditions | Maximum Ratings | |
|-------------------------------|---|---|------------------|
| V_{CES} | $T_J = 25^\circ\text{C to } 175^\circ\text{C}$ | 600 | V |
| V_{CGR} | $T_J = 25^\circ\text{C to } 175^\circ\text{C}, R_{GE} = 1\text{M}\Omega$ | 600 | V |
| V_{GES} | Continuous | ± 20 | V |
| V_{GEM} | Transient | ± 30 | V |
| I_{C25} | $T_C = 25^\circ\text{C}$ (Chip Capability) | 223 | A |
| I_{C110} | $T_C = 110^\circ\text{C}$ | 120 | A |
| I_{CM} | $T_C = 25^\circ\text{C}, 1\text{ms}$ | 1000 | A |
| I_A | $T_C = 25^\circ\text{C}$ | 100 | A |
| E_{AS} | $T_C = 25^\circ\text{C}$ | 1 | J |
| SSOA (RBSOA) | $V_{GE} = 15\text{V}, T_{VJ} = 150^\circ\text{C}, R_G = 1\Omega$ Clamped Inductive Load | $I_{CM} = 400$ @ $V_{CE} \leq V_{CES}$ | A |
| t_{sc} (SCSOA) | $V_{GE} = 15\text{V}, V_{CE} = 360\text{V}, T_J = 150^\circ\text{C}$ $R_G = 10\Omega$, Non Repetitive | 10 | μs |
| P_C | $T_C = 25^\circ\text{C}$ | 625 | W |
| T_J | | -55 ... +175 | $^\circ\text{C}$ |
| T_{JM} | | 175 | $^\circ\text{C}$ |
| T_{stg} | | -55 ... +175 | $^\circ\text{C}$ |
| T_L | Maximum Lead Temperature for Soldering | 300 | $^\circ\text{C}$ |
| T_{SOLD} | 1.6 mm (0.062 in.) from Case for 10 | 260 | $^\circ\text{C}$ |
| V_{ISOL} | 50/60Hz, 1 minute | 2500 | V~ |
| F_C | Mounting Force | 50..200/11..45 | N/lb. |
| Weight | | 8 | g |


 G = Gate E = Emitter
 C = Collector

Features

- Silicon Chip on Direct-Copper Bond (DCB) Substrate
- Isolated Mounting Surface
- 2500V~ Electrical Isolation
- Optimized for Low Conduction and Switching Losses
- Avalanche Rated
- Short Circuit Capability
- Very High Current Capability
- Square RBSOA

Advantages

- High Power Density
- Low Gate Drive Requirement

Applications

- Power Inverters
- UPS
- Motor Drives
- SMPS
- PFC Circuits
- Battery Chargers
- Welding Machines
- Lamp Ballasts

| Symbol | Test Conditions ($T_J = 25^\circ\text{C}$, Unless Otherwise Specified) | Characteristic Values | | |
|---------------|--|-----------------------|------|--------------------------|
| | | Min. | Typ. | Max. |
| BV_{CES} | $I_C = 250\mu\text{A}, V_{GE} = 0\text{V}$ | 600 | | V |
| $V_{GE(th)}$ | $I_C = 250\mu\text{A}, V_{CE} = V_{GE}$ | 3.5 | | 6.0 V |
| I_{CES} | $V_{CE} = V_{CES}, V_{GE} = 0\text{V}$ Note 2, $T_J = 150^\circ\text{C}$ | | | 50 μA 3 mA |
| I_{GES} | $V_{CE} = 0\text{V}, V_{GE} = \pm 20\text{V}$ | | | ± 200 nA |
| $V_{CE(sat)}$ | $I_C = 100\text{A}, V_{GE} = 15\text{V}$, Note 1 $T_J = 150^\circ\text{C}$ | 1.40 | 1.58 | V V |

| Symbol Test Conditions ($T_J = 25^\circ\text{C}$ Unless Otherwise Specified) | | Characteristic Values | | |
|--|--|-----------------------|------|-------------------------|
| | | Min. | Typ. | Max. |
| g_{fs} | $I_C = 60\text{A}, V_{CE} = 10\text{V}$, Note 1 | 27 | 45 | S |
| C_{ies} | $V_{CE} = 25\text{V}, V_{GE} = 0\text{V}, f = 1\text{MHz}$ | | 9970 | pF |
| C_{oes} | | | 570 | pF |
| C_{res} | | | 183 | pF |
| $Q_{g(on)}$ | $I_C = 200\text{A}, V_{GE} = 15\text{V}, V_{CE} = 0.5 \cdot V_{CES}$ | | 315 | nC |
| Q_{ge} | | | 98 | nC |
| Q_{gc} | | | 130 | nC |
| $t_{d(on)}$ | Inductive load, $T_J = 25^\circ\text{C}$ $I_C = 100\text{A}, V_{GE} = 15\text{V}$ $V_{CE} = 360\text{V}, R_G = 1\Omega$ Note 3 | | 48 | ns |
| t_{ri} | | | 100 | ns |
| E_{on} | | | 2.85 | mJ |
| $t_{d(off)}$ | | | 160 | ns |
| t_{fi} | | | 110 | ns |
| E_{off} | | | 2.90 | 4.40 mJ |
| $t_{d(on)}$ | Inductive load, $T_J = 150^\circ\text{C}$ $I_C = 100\text{A}, V_{GE} = 15\text{V}$ $V_{CE} = 360\text{V}, R_G = 1\Omega$ Note 3 | | 46 | ns |
| t_{ri} | | | 94 | ns |
| E_{on} | | | 4.40 | mJ |
| $t_{d(off)}$ | | | 180 | ns |
| t_{fi} | | | 215 | ns |
| E_{off} | | | 3.45 | mJ |
| R_{thJC} | | | | 0.24 $^\circ\text{C/W}$ |
| R_{thCS} | | 0.05 | | $^\circ\text{C/W}$ |

Notes:

1. Pulse test, $t \leq 300\mu\text{s}$, duty cycle, $d \leq 2\%$.
2. Part must be heatsunk for high-temp I_{CES} measurement.
3. Switching times & energy losses may increase for higher $V_{CE}(\text{Clamp})$, T_J or R_G .

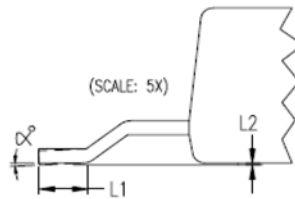
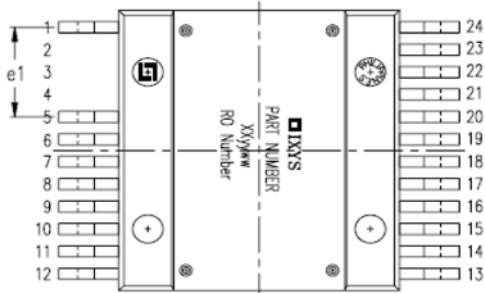
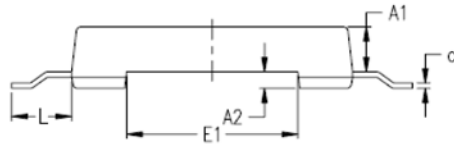
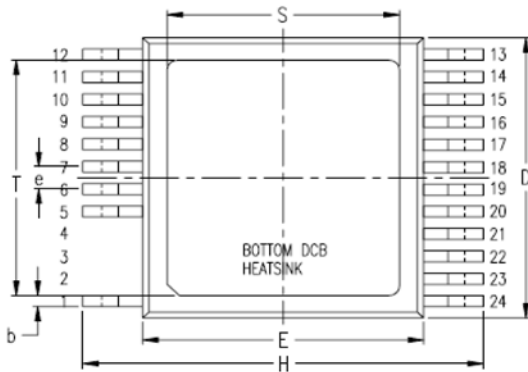
PRELIMINARY TECHNICAL INFORMATION

The product presented herein is under development. The Technical Specifications offered are derived from a subjective evaluation of the design, based upon prior knowledge and experience, and constitute a "considered reflection" of the anticipated result. IXYS reserves the right to change limits, test conditions, and dimensions without notice.

IXYS Reserves the Right to Change Limits, Test Conditions, and Dimensions.

IXYS MOSFETs and IGBTs are covered by one or more of the following U.S. patents:

| | | | | | | | | | |
|-----------|-----------|-----------|-----------|--------------|--------------|--------------|--------------|--------------|-------------|
| 4,835,592 | 4,931,844 | 5,049,961 | 5,237,481 | 6,162,665 | 6,404,065 B1 | 6,683,344 | 6,727,585 | 7,005,734 B2 | 7,157,338B2 |
| 4,860,072 | 5,017,508 | 5,063,307 | 5,381,025 | 6,259,123 B1 | 6,534,343 | 6,710,405 B2 | 6,759,692 | 7,063,975 B2 | |
| 4,881,106 | 5,034,796 | 5,187,117 | 5,486,715 | 6,306,728 B1 | 6,583,505 | 6,710,463 | 6,771,478 B2 | 7,071,537 | |



| SYM | INCHES | | MILLIMETERS | |
|-----|----------|-------|-------------|-------|
| | MIN | MAX | MIN | MAX |
| A | .209 | .224 | 5.30 | 5.70 |
| A1 | .154 | .161 | 3.90 | 4.10 |
| A2 | .055 | .063 | 1.40 | 1.60 |
| b | .035 | .045 | 0.90 | 1.15 |
| c | .018 | .026 | 0.45 | 0.65 |
| D | .976 | .994 | 24.80 | 25.25 |
| E | .898 | .915 | 22.80 | 23.25 |
| E1 | .543 | .559 | 13.80 | 14.20 |
| e | .079 BSC | | 2.00 BSC | |
| e1 | .315 BSC | | 8.00 BSC | |
| H | 1.272 | 1.311 | 32.30 | 33.30 |
| L | .181 | .209 | 4.60 | 5.30 |
| L1 | .051 | .067 | 1.30 | 1.70 |
| L2 | .000 | .006 | 0.00 | 0.15 |
| S | .736 | .760 | 18.70 | 19.30 |
| T | .815 | .839 | 20.70 | 21.30 |
| α | 0 | 4° | 0 | 4° |

PIN: 1 = Gate
5-12 = Emitter
13-24 = Collector

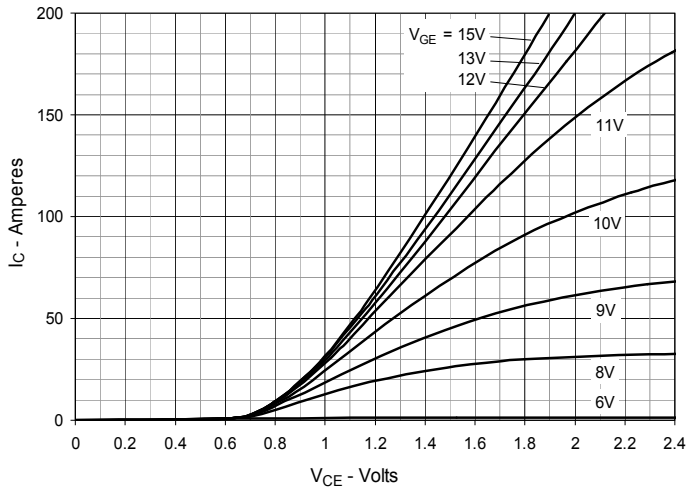
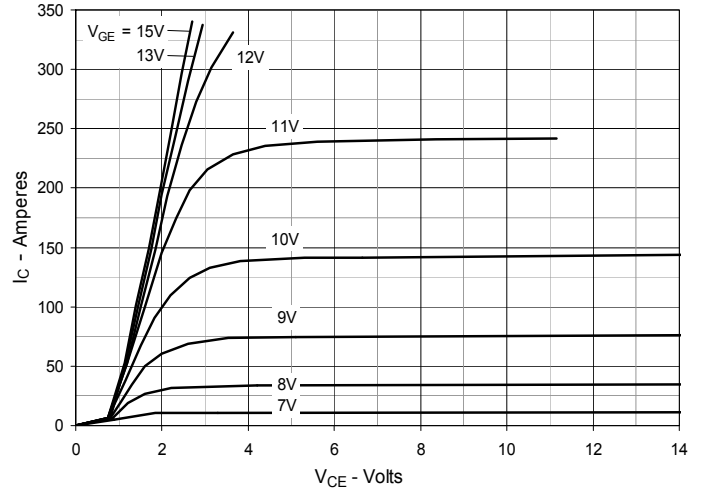
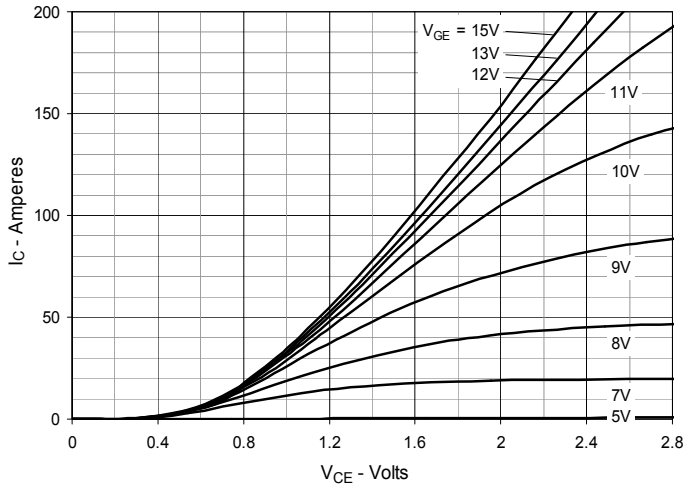
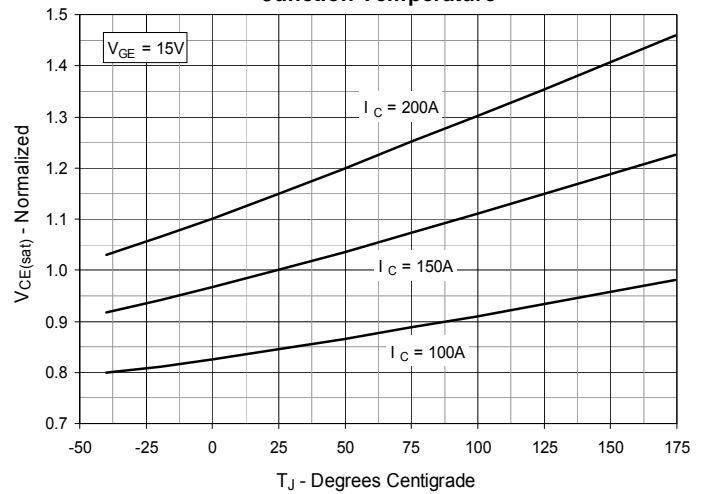
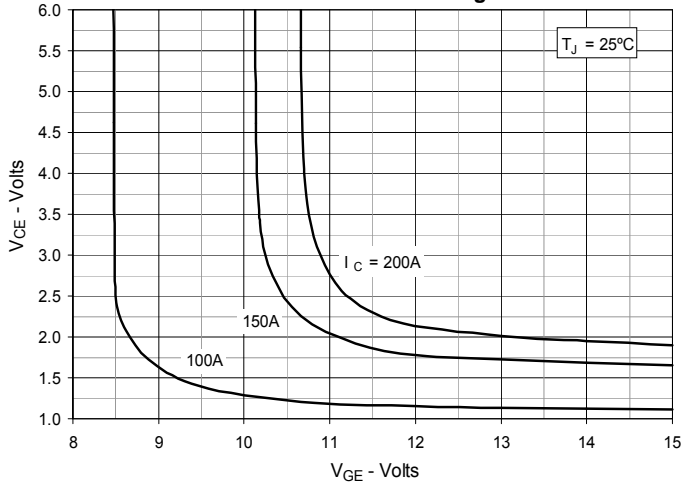
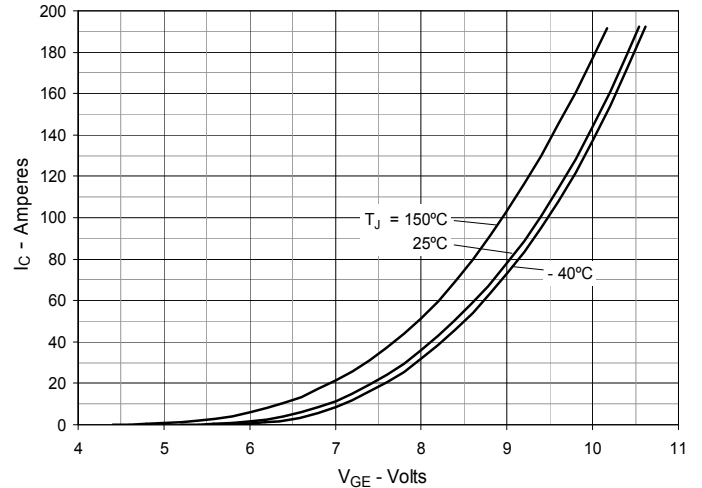
Fig. 1. Output Characteristics @ $T_J = 25^\circ\text{C}$

Fig. 2. Extended Output Characteristics @ $T_J = 25^\circ\text{C}$

Fig. 3. Output Characteristics @ $T_J = 150^\circ\text{C}$

Fig. 4. Dependence of $V_{CE(sat)}$ on Junction Temperature

Fig. 5. Collector-to-Emitter Voltage vs. Gate-to-Emitter Voltage

Fig. 6. Input Admittance


Fig. 7. Transconductance

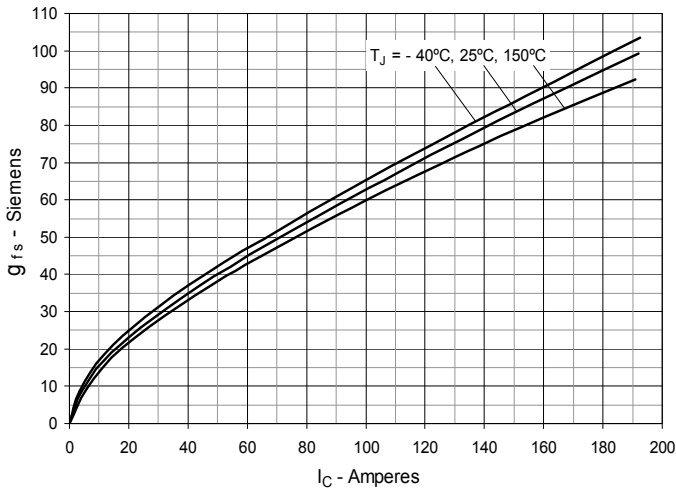


Fig. 8. Gate Charge

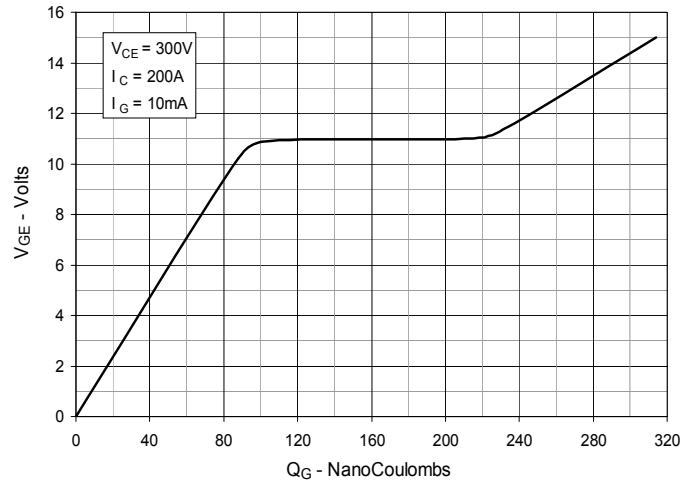


Fig. 9. Capacitance

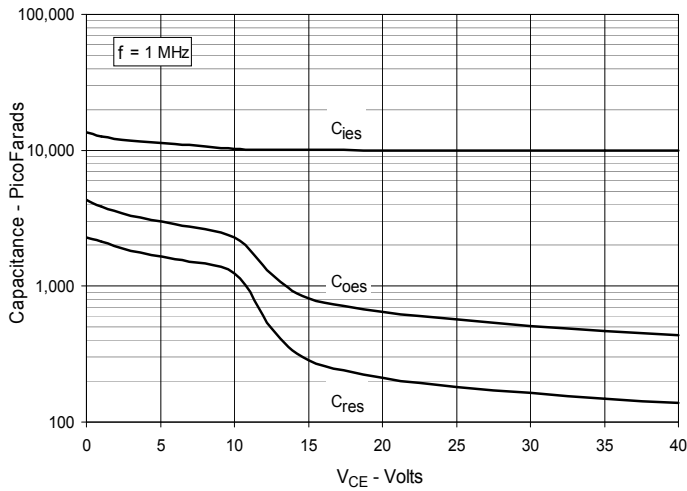


Fig. 10. Reverse-Bias Safe Operating Area

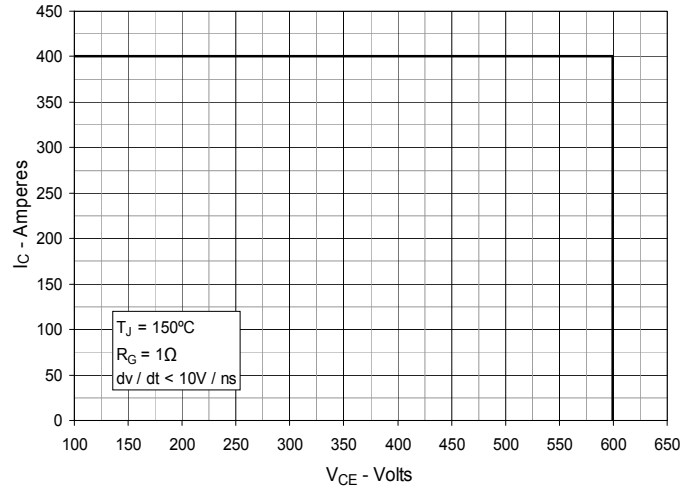


Fig. 11. Forward-Bias Safe Operating Area

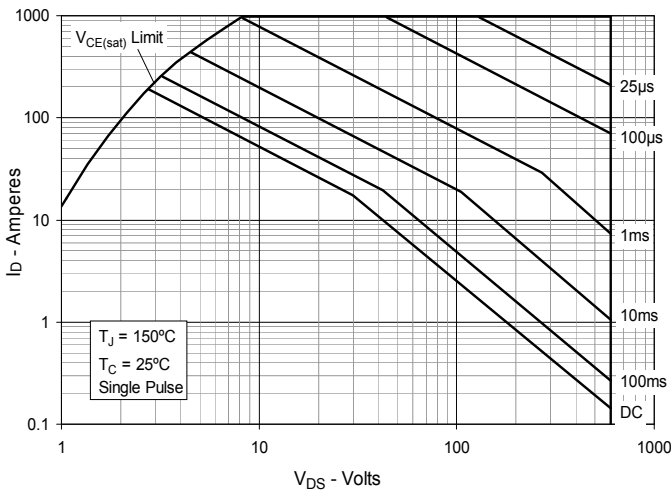


Fig. 12. Maximum Transient Thermal Impedance

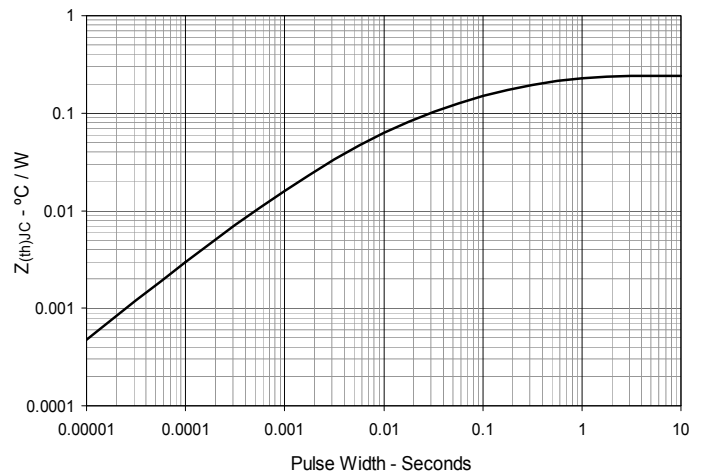


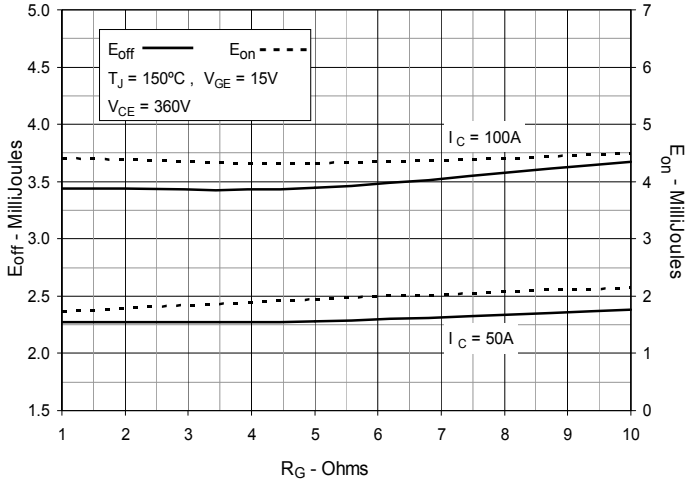
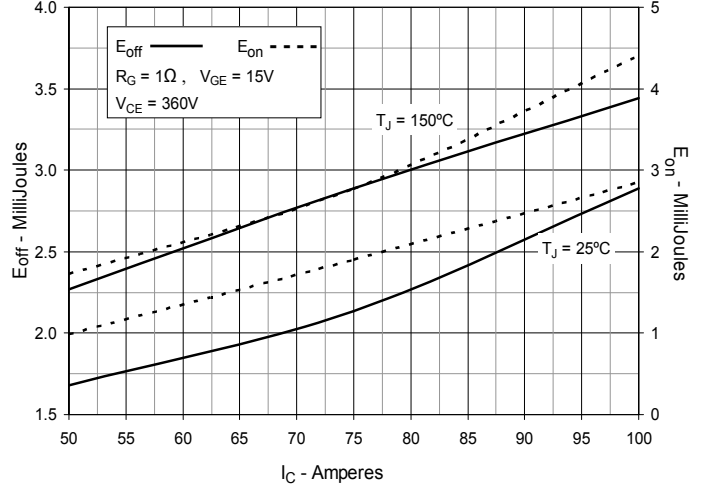
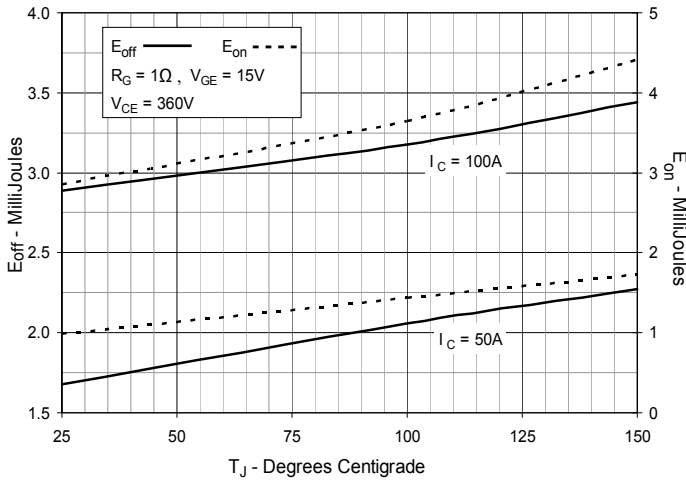
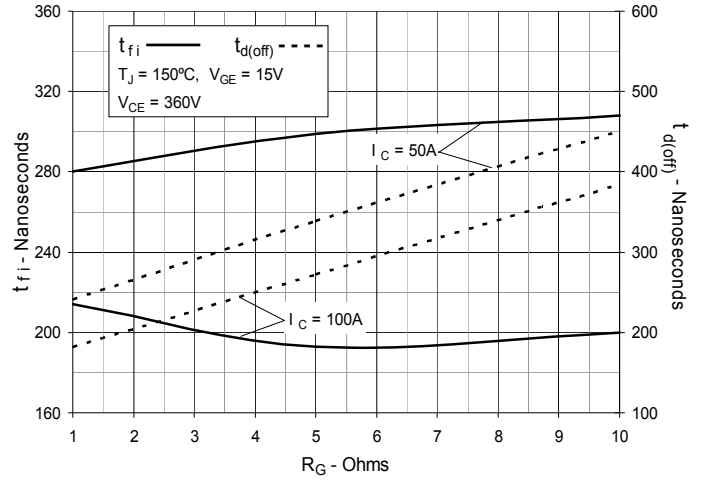
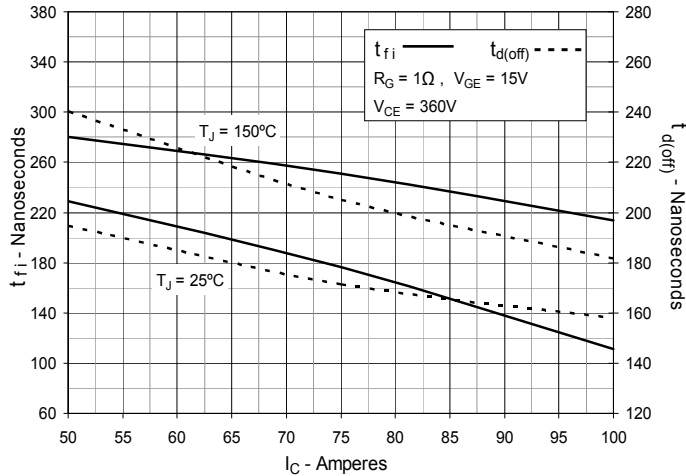
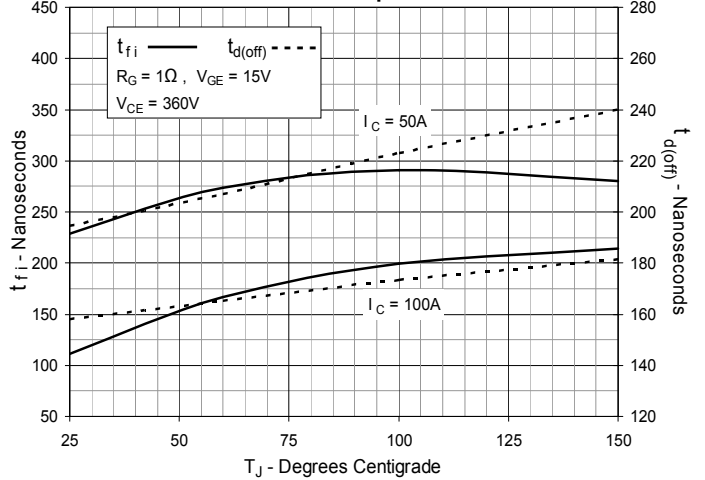
Fig. 13. Inductive Switching Energy Loss vs. Gate Resistance

Fig. 14. Inductive Switching Energy Loss vs. Collector Current

Fig. 15. Inductive Switching Energy Loss vs. Junction Temperature

Fig. 16. Inductive Turn-off Switching Times vs. Gate Resistance

Fig. 17. Inductive Turn-off Switching Times vs. Collector Current

Fig. 18. Inductive Turn-off Switching Times vs. Junction Temperature


Fig. 19. Inductive Turn-on Switching Times vs. Gate Resistance

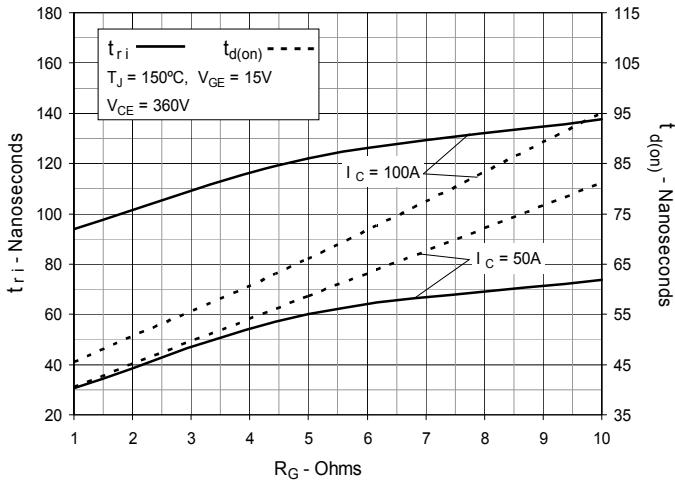


Fig. 20. Inductive Turn-on Switching Times vs. Collector Current

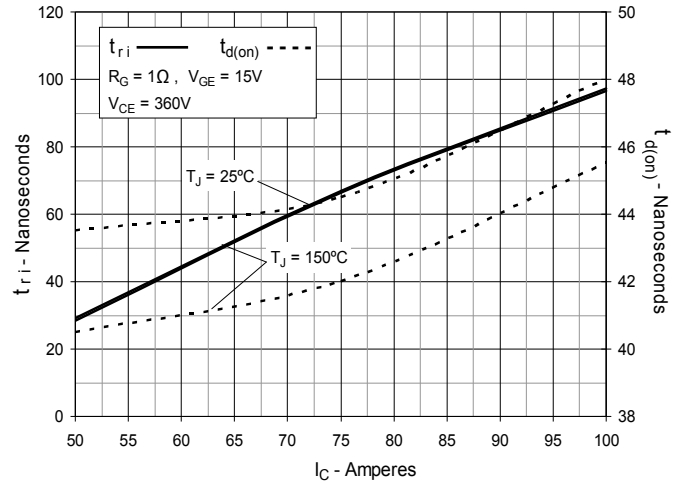
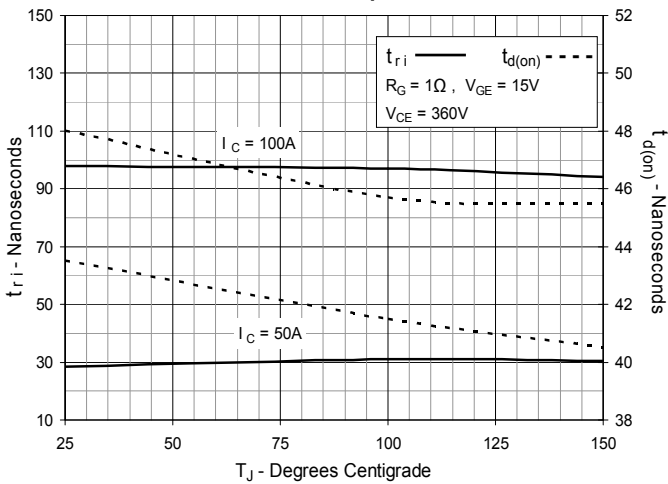


Fig. 21. Inductive Turn-on Switching Times vs. Junction Temperature





Disclaimer Notice - Information furnished is believed to be accurate and reliable. However, users should independently evaluate the suitability of and test each product selected for their own applications. Littelfuse products are not designed for, and may not be used in, all applications. Read complete Disclaimer Notice at www.littelfuse.com/disclaimer-electronics.